

FCC 47 CFR PART 24 SUBPART E TEST REPORT

For

Applicant: SHENZHEN KONKA TELECOMMUNICATION

TECHNOLOGY CO., LTD.

Address: No.9008 Shennan Road, Overseas Chinese Town,

Shenzhen, Guangdong, China

Product Name: GSM Dual Band GPRS Digital Mobile Phone

Model Name: TV9

Brand Name: bmobile

FCC ID: UT3KKTV9

Report No.: STS100408F3

Date of Issue: April 28, 2010

Issued by: Shenzhen Super Test Service Technology Co., Ltd.

No.5, Nangshan 2nd Rd., North Hi-Tech Industrial Park ,Nanshan, Address :

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1. VERIFICATION OF CONFORMITY

Equipment Under Test: GSM Dual Band GPRS Digital Mobile Phone

Brand Name: bmobile
Model Number: TV9

FCC ID: UT3KKTV9

Applicant: SHENZHEN KONKA TELECOMMUNICATION TECHNOLOGY CO., LTD.

No.9008 Shennan Road, Overseas Chinese Town, Shenzhen, Guangdong,

China

Manufacturer: SHENZHEN KONKA TELECOMMUNICATION TECHNOLOGY CO., LTD.

No.9008 Shennan Road, Overseas Chinese Town, Shenzhen, Guangdong,

China

Technical Standards: 47 CFR Part 2

47 CFR Part 24 Subpart E

File Number: STS100408F3

Date of test: April 20, 2010 ~ April 28, 2010

Deviation: None
Condition of Test Sample: Normal
Test Result: PASS

The above equipment was tested by Most Technology Service Co., Ltd. for compliance with the requirements set forth in FCC rules and the Technical Standards mentioned above. This said equipment in the configuration described in this report shows the maximum emission levels emanating from equipment and the level of the immunity endurance of the equipment are within the compliance requirements.

The test results of this report relate only to the tested sample identified in this report.

Tested by (+ signature):	letter fing	
Review by (+ signature):	Petter Ping April 28, 2010	
	July Wen April 28, 2010	
Approved by (+ signature):	Tong Pang	
_	Terry Yang April 28, 2010	

2. GENERAL INFORMATION

2.1 Product Information

FUTA Makila Dharas	
EUT1- Mobile Phone	T
Description:	GSM Dual Band GPRS Digital Mobile Phone
Model Name:	TV9
Serial No.:	N/A
IMEI No.:	359812030043223
Frequency:	GSM 850MHz/1900MHz
Hardware Version:	v1.2
Software Version:	KAATV9_TLC_En_CH_0.97.322
EUT2- Battery	
Description:	Lithium-ion Battery
Model Name:	KLB100N152
Brand Name:	bmoible
Manufacturer:	SHENZHEN KONKA TELECOMMUNICATION TECHNOLOGY CO., LTD.
Capacitance:	1000 mAh
Rated Voltage:	3.7V
Charge Limit:	4.2V
EUT3 – Power Supply	
Description:	Travel Charger
Model Name:	KTC-08USB-D
Brand Name:	bmoible
Manufacturer:	SHENZHEN KONKA TELECOMMUNICATION TECHNOLOGY CO., LTD.
Rated Input:	AC 100-240V, 50/60HZ 150mA
Rated Output:	DC 5.0V, 500mA
Length USB cable:	1.00m

NOTE:

- 1. The normal configuration for the EUT is the Mobile Phone (MS) associated with ancillary equipments e.g. the Battery, Earphone, USB Cable and/or the AC Adapter (Charger).
- 2. The transmitter (Tx) frequency arrangement of the PCS 1900MHz band for the EUT can be represented with a formula F(n)=1850.2+0.2*(n-512), $512 \le n \le 810$.
- 3. The normal, high and low voltage supply for the Battery of the EUT is separately 3.7V, 4.2V and 3.6V, which are specified by the applicant.
- 4. Please refer to Appendix I for the photographs of the EUT. For a more detailed features description about the EUT, please refer to User's Manual.

2.2 Objective

The objective of the report is to perform tests according to 47 CFR Part 2, Part 24 for FCC ID Certification:

No.	Identity	Document Title			
1	47 CFR Part 2 (10-1-05 Edition)	Frequency Allocations and Radio Treaty Matters; General Rules and Regulations			
2	47 CFR Part 24 (10-1-05 Edition)	Personal Communications Services			

2.3 Test Standards and Results

Test items and the results are as bellow:

No.	Rules	Test Type	Result	Date of Test
1	§2.106 §24.229	Frequencies	PASS	2010-04-27
2	§2.1046	Conducted RF Output Power at Antenna Terminal	PASS	2010-04-27
3	§2.1049	Occupied Bandwidth	PASS	2010-04-27
4	§2.1051 §2.1057 §24.238	Conducted Spurious Emission at Antenna Terminal	PASS	2010-04-27
5	§24.232	Transmitter Radiated Power (EIPR/ERP)	PASS	2010-04-27
6	§2.1053 §2.1057 §24.238	Radiated Spurious Emission	PASS	2010-04-27
7	§2.1055 §24.235	Frequency Stability	PASS	2010-04-27

Note: 1. The test result judgment is decided by the limit of measurement standard

2. The information of measurement uncertainty is available upon the customer's request.

2.4 Environmental Conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature: 15-35°CHumidity: 30-60 %

- Atmospheric pressure: 86-106 kPa

3. TEST FACILITY

Test Site: Most Technology Service Co., Ltd.

Location: No.5, Langshan 2nd Rd., North Hi-Tech Industrial park , Nanshan,

Shenzhen, Guangdong, China

Description: There is one 3m semi-anechoic an area test sites and two line conducted labs for final

test. The Open Area Test Sites and the Line Conducted labs are constructed and calibrated to meet the FCC requirements in documents ANSI C63.4:2003 and CISPR

16 requirements. The FCC Registration Number is 490827.

Site Filing: The site description is on file with the Federal Communications

Commission, 7435 Oakland Mills Road, Columbia, MD 21046.

Instrument Tolerance: All measuring equipment is in accord with ANSI C63.4:2003 and CISPR 16

requirements that meet industry regulatory agency and accreditation agency

requirement.

Ground Plane: Two conductive reference ground planes were used during the Line Conducted

Emission, one in vertical and the other in horizontal. The dimensions of these ground planes are as below. The vertical ground plane was placed distancing 40 cm to the rear of the wooden test table on where the EUT and the support equipment were placed during test. The horizontal ground plane projected 50 cm beyond the footprint of the EUT system and distanced 80 cm to the wooden test table. For Radiated Emission Test, one horizontal conductive ground plane extended at least 1m beyond

the periphery of the EUT and the largest measuring antenna, and covered the entire

area between the EUT and the antenna.

4. TEST EQUIPMENT LIST

Instrumentation: The following list contains equipment used at Most for testing. The equipment conforms to the CISPR 16-1 / ANSI C63.2 Specifications for Electromagnetic Interference and Field Strength

Instrumentation from 10 kHz to 1.0 GHz or above.

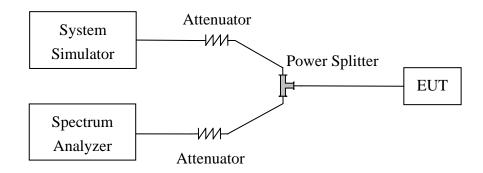
1 Test Receiver Rohde & Schwarz ESCI 100492 2 L.I.S.N. Rohde & Schwarz ENV216 100093 3 Coaxial Switch Anritsu Corp MP59B 6200283933 4 Terminator Hubersuhner 50Ω No.1 5 RF Cable SchwarzBeck N/A No.1 6 Test Receiver Rohde & Schwarz ESPI 101202 7 Bilog Antenna Sunol JB3 A121206 8 Cable SchwarzBeck N/A NO.1 9 Cable SchwarzBeck N/A NO.2 10 Cable SchwarzBeck N/A NO.3 11 DC Power Filter DuoJi DL2×30B N/A 12 Single Phase Power Line Filter DuoJi FNF 202B30 N/A 13 3 Phase Power Line Filter DuoJi FNF 402B30 N/A 14 Test Receiver Rohde & Schwarz ESCI 100492 15	2011/03/1 2011/03/1 2011/03/1 2011/03/1 2011/03/1 2011/03/1 2011/03/1 2011/03/1
Coaxial Switch	2011/03/1 2011/03/1 2011/03/1 2011/03/1 2011/03/1
4 Terminator Hubersuhner 50Ω No.1 5 RF Cable SchwarzBeck N/A No.1 6 Test Receiver Rohde & Schwarz ESPI 101202 7 Bilog Antenna Sunol JB3 A121206 8 Cable SchwarzBeck N/A NO.1 9 Cable SchwarzBeck N/A NO.2 10 Cable SchwarzBeck N/A NO.3 11 DC Power Filter DuoJi DL2×30B N/A 12 Single Phase Power Line Filter DuoJi FNF 202B30 N/A 13 3 Phase Power Line Filter DuoJi FNF 402B30 N/A 14 Test Receiver Rohde & Schwarz ESCI 100492 15 Absorbing Clamp Luthi MDS21 3635 16 Coaxial Switch Anritsu Corp MP59B 6200283933 17 AC Power Source Kikusui KHA1000 LM003720 18 <td< td=""><td>2011/03/1 2011/03/1 2011/03/1 2011/03/1 2011/03/1</td></td<>	2011/03/1 2011/03/1 2011/03/1 2011/03/1 2011/03/1
5 RF Cable SchwarzBeck N/A No.1 6 Test Receiver Rohde & Schwarz ESPI 101202 7 Bilog Antenna Sunol JB3 A121206 8 Cable SchwarzBeck N/A NO.1 9 Cable SchwarzBeck N/A NO.2 10 Cable SchwarzBeck N/A NO.3 11 DC Power Filter DuoJi DL2×30B N/A 12 Single Phase Power Line Filter DuoJi FNF 202B30 N/A 13 3 Phase Power Line Filter DuoJi FNF 402B30 N/A 14 Test Receiver Rohde & Schwarz ESCI 100492 15 Absorbing Clamp Luthi MDS21 3635 16 Coaxial Switch Anritsu Corp MP59B 6200283933 17 AC Power Source Kikusui KHA1000 LM003720 18 Test Analyzer Kikusui KHA1000 LM003720 19	2011/03/1 2011/03/1 2011/03/1 2011/03/1
6 Test Receiver Rohde & Schwarz ESPI 101202 7 Bilog Antenna Sunol JB3 A121206 8 Cable SchwarzBeck N/A NO.1 9 Cable SchwarzBeck N/A NO.2 10 Cable SchwarzBeck N/A NO.3 11 DC Power Filter DuoJi DL2×30B N/A 12 Single Phase Power Line Filter DuoJi FNF 202B30 N/A 13 3 Phase Power Line Filter DuoJi FNF 402B30 N/A 14 Test Receiver Rohde & Schwarz ESCI 100492 15 Absorbing Clamp Luthi MDS21 3635 16 Coaxial Switch Anritsu Corp MP59B 6200283933 17 AC Power Source Kikusui AC40MA LM003232 18 Test Analyzer Kikusui KHA1000 LM003720 19 Line Impendence Network Kikusui KES4021 LM003537	2011/03/1 2011/03/1 2011/03/1
7 Bilog Antenna Sunol JB3 A121206 8 Cable SchwarzBeck N/A NO.1 9 Cable SchwarzBeck N/A NO.2 10 Cable SchwarzBeck N/A NO.3 11 DC Power Filter DuoJi DL2×30B N/A 12 Single Phase Power Line Filter DuoJi FNF 202B30 N/A 13 3 Phase Power Line Filter DuoJi FNF 402B30 N/A 14 Test Receiver Rohde & Schwarz ESCI 100492 15 Absorbing Clamp Luthi MDS21 3635 16 Coaxial Switch Anritsu Corp MP59B 6200283933 17 AC Power Source Kikusui AC40MA LM003232 18 Test Analyzer Kikusui KHA1000 LM003720 19 Line Impendence Network Kikusui KES4021 LM003537 20 ESD Tester Kikusui KES4021 LM003537 <t< td=""><td>2011/03/1</td></t<>	2011/03/1
8 Cable SchwarzBeck N/A NO.1 9 Cable SchwarzBeck N/A NO.2 10 Cable SchwarzBeck N/A NO.3 11 DC Power Filter DuoJi DL2×30B N/A 12 Single Phase Power Line Filter DuoJi FNF 202B30 N/A 13 3 Phase Power Line Filter DuoJi FNF 402B30 N/A 14 Test Receiver Rohde & Schwarz ESCI 100492 15 Absorbing Clamp Luthi MDS21 3635 16 Coaxial Switch Anritsu Corp MP59B 6200283933 17 AC Power Source Kikusui AC40MA LM003232 18 Test Analyzer Kikusui KHA1000 LM003720 19 Line Impendence Network Kikusui KIKusui KES4021 LM002352 20 ESD Tester Kikusui KES4021 LM003537 21 EMCPRO System EM Test UCS-500-M4 V064810	2011/03/1
9 Cable SchwarzBeck N/A NO.2 10 Cable SchwarzBeck N/A NO.3 11 DC Power Filter DuoJi DL2×30B N/A 12 Single Phase Power Line Filter DuoJi FNF 202B30 N/A 13 3 Phase Power Line Filter DuoJi FNF 402B30 N/A 14 Test Receiver Rohde & Schwarz ESCI 100492 15 Absorbing Clamp Luthi MDS21 3635 16 Coaxial Switch Anritsu Corp MP59B 6200283933 17 AC Power Source Kikusui AC40MA LM003232 18 Test Analyzer Kikusui KHA1000 LM003720 19 Line Impendence Network Kikusui KIKusui KES4021 LM002352 20 ESD Tester Kikusui KES4021 LM003537 21 EMCPRO System EM Test UCS-500-M4 V0648102026 22 Signal Generator IFR 2032	
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11 DC Power Filter DuoJi DL2×30B N/A 12 Single Phase Power Line Filter DuoJi FNF 202B30 N/A 13 3 Phase Power Line Filter DuoJi FNF 402B30 N/A 14 Test Receiver Rohde & Schwarz ESCI 100492 15 Absorbing Clamp Luthi MDS21 3635 16 Coaxial Switch Anritsu Corp MP59B 6200283933 17 AC Power Source Kikusui AC40MA LM003232 18 Test Analyzer Kikusui KHA1000 LM003720 19 Line Impendence Network Kikusui KES4021 LM002352 20 ESD Tester Kikusui KES4021 LM003537 21 EMCPRO System EM Test UCS-500-M4 V0648102026 22 Signal Generator IFR 2032 203002/100 23 Amplifier A&R 150W1000 301584 24 CDN FCC FCC-801-M3-25 47	2011/03/1
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12 Filter DuoJi FNF 202B30 N/A 13 3 Phase Power Line Filter DuoJi FNF 402B30 N/A 14 Test Receiver Rohde & Schwarz ESCI 100492 15 Absorbing Clamp Luthi MDS21 3635 16 Coaxial Switch Anritsu Corp MP59B 6200283933 17 AC Power Source Kikusui AC40MA LM003232 18 Test Analyzer Kikusui KHA1000 LM003720 19 Line Impendence Network Kikusui LIN40MA-PCR-L LM002352 20 ESD Tester Kikusui KES4021 LM003537 21 EMCPRO System EM Test UCS-500-M4 V0648102026 22 Signal Generator IFR 2032 203002/100 23 Amplifier A&R 150W1000 301584 24 CDN FCC FCC-801-M3-25 47 25 CDN FCC FCC-801-M3-25 107	2011/03/1
14 Test Receiver Rohde & Schwarz ESCI 100492 15 Absorbing Clamp Luthi MDS21 3635 16 Coaxial Switch Anritsu Corp MP59B 6200283933 17 AC Power Source Kikusui AC40MA LM003232 18 Test Analyzer Kikusui KHA1000 LM003720 19 Line Impendence Network Kikusui LIN40MA-PCR-L LM002352 20 ESD Tester Kikusui KES4021 LM003537 21 EMCPRO System EM Test UCS-500-M4 V0648102026 22 Signal Generator IFR 2032 203002/100 23 Amplifier A&R 150W1000 301584 24 CDN FCC FCC-801-M2-25 47 25 CDN FCC FCC-801-M3-25 107	2011/03/1
15 Absorbing Clamp Luthi MDS21 3635 16 Coaxial Switch Anritsu Corp MP59B 6200283933 17 AC Power Source Kikusui AC40MA LM003232 18 Test Analyzer Kikusui KHA1000 LM003720 19 Line Impendence Network Kikusui LIN40MA-PCR-L LM002352 20 ESD Tester Kikusui KES4021 LM003537 21 EMCPRO System EM Test UCS-500-M4 V0648102026 22 Signal Generator IFR 2032 203002/100 23 Amplifier A&R 150W1000 301584 24 CDN FCC FCC-801-M2-25 47 25 CDN FCC FCC-801-M3-25 107	2011/03/1
16 Coaxial Switch Anritsu Corp MP59B 6200283933 17 AC Power Source Kikusui AC40MA LM003232 18 Test Analyzer Kikusui KHA1000 LM003720 19 Line Impendence Network Kikusui LIN40MA-PCR-L LM002352 20 ESD Tester Kikusui KES4021 LM003537 21 EMCPRO System EM Test UCS-500-M4 V0648102026 22 Signal Generator IFR 2032 203002/100 23 Amplifier A&R 150W1000 301584 24 CDN FCC FCC-801-M2-25 47 25 CDN FCC FCC-801-M3-25 107	2011/03/1
17 AC Power Source Kikusui AC40MA LM003232 18 Test Analyzer Kikusui KHA1000 LM003720 19 Line Impendence Network Kikusui LIN40MA-PCR-L LM002352 20 ESD Tester Kikusui KES4021 LM003537 21 EMCPRO System EM Test UCS-500-M4 V0648102026 22 Signal Generator IFR 2032 203002/100 23 Amplifier A&R 150W1000 301584 24 CDN FCC FCC-801-M2-25 47 25 CDN FCC FCC-801-M3-25 107	2011/03/1
18 Test Analyzer Kikusui KHA1000 LM003720 19 Line Impendence Network Kikusui LIN40MA-PCR-L PCR-L PCR-L LM002352 LM002352 20 ESD Tester Kikusui KES4021 LM003537 21 EMCPRO System EM Test UCS-500-M4 V0648102026 22 Signal Generator IFR 2032 203002/100 23 Amplifier A&R 150W1000 301584 24 CDN FCC FCC-801-M2-25 47 25 CDN FCC FCC-801-M3-25 107	2011/03/1
19 Line Impendence Network Kikusui LIN40MA-PCR-L PCR-L PCR-L LM002352 20 ESD Tester Kikusui KES4021 LM003537 21 EMCPRO System EM Test UCS-500-M4 V0648102026 22 Signal Generator IFR 2032 203002/100 23 Amplifier A&R 150W1000 301584 24 CDN FCC FCC-801-M2-25 47 25 CDN FCC FCC-801-M3-25 107	2011/03/1
19 Line Impendence Network Kikusul PCR-L LM002352 20 ESD Tester Kikusul KES4021 LM003537 21 EMCPRO System EM Test UCS-500-M4 V0648102026 22 Signal Generator IFR 2032 203002/100 23 Amplifier A&R 150W1000 301584 24 CDN FCC FCC-801-M2-25 47 25 CDN FCC FCC-801-M3-25 107	2011/03/1
21 EMCPRO System EM Test UCS-500-M4 V0648102026 22 Signal Generator IFR 2032 203002/100 23 Amplifier A&R 150W1000 301584 24 CDN FCC FCC-801-M2-25 47 25 CDN FCC FCC-801-M3-25 107	2011/03/1
22 Signal Generator IFR 2032 203002/100 23 Amplifier A&R 150W1000 301584 24 CDN FCC FCC-801-M2-25 47 25 CDN FCC FCC-801-M3-25 107	2011/03/1
23 Amplifier A&R 150W1000 301584 24 CDN FCC FCC-801-M2-25 47 25 CDN FCC FCC-801-M3-25 107	2011/03/1
24 CDN FCC FCC-801-M2-25 47 25 CDN FCC FCC-801-M3-25 107	2011/03/1
25 CDN FCC FCC-801-M3-25 107	2011/03/1
	2011/03/1
	2011/03/1
26 EM Injection Clamp FCC F-203I-23mm 403	2011/03/1
27 RF Cable MIYAZAKI N/A No.1/No.2	2011/03/1
28 Universal Radio Communication Tester ROHDE&SCHWARZ CMU200 0304789	2011/03/1
29 Telecommunication Antenna European Antennas PSA 75301R/170 0304213	2011/02/1
30 Spectrum Analyzer Agilent E4408 MY41440460	2011/03/1
31 Horn Antenna SCHWARZBECK BBHA9120D D69250	2011/03/1

NOTE: Equipments listed above have been calibrated and are in the period of validation.

5. 47 CFR Part 2, Part 24E Requirements

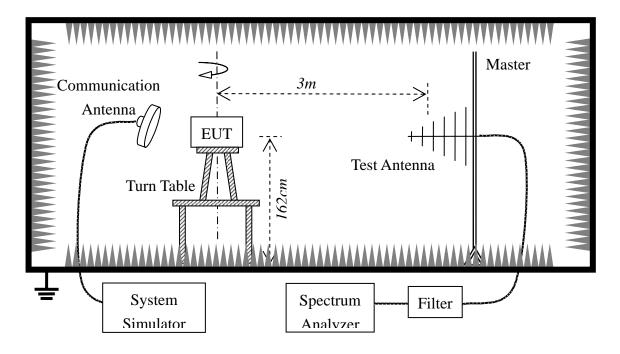
5.1 General Information

5.1.1 Conducted Related Tests



- 1. The EUT is coupled to the Spectrum Analyzer and the System Simulator with the suitable Attenuators through the Power Splitter; the path loss is calibrated to correct the reading.
- 2. The EUT is configured here as MS + Battery.
- 3. The EUT is commanded via the System Simulator (SS) to operate at the maximum output power i.e. Power Control Level (PCL) = 0 and Power Class = 1.
- 4. The BCCH number of the SS used here is 520. A communication link is established between the EUT and the SS.
- 5. The Spectrum Analyzer is set to max-peak detector function and maximum hold mode.

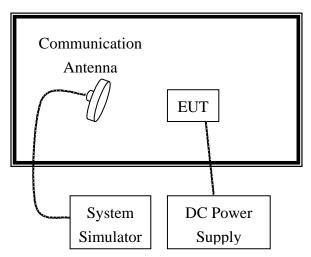
5.1.2 Radiated Power and Spurious Emission Tests



1. The test is performed in a full-Anechoic Chamber; the air loss of the site and the factors of the test system are pre-calibrated using the substitution method.

- 2. The EUT is configured as MS + Battery.
- 3. The EUT is placed on the vertical axis of a Turn Table 1.62 meters above the ground.
- 4. The Test Antenna is a bi-log one or a horn one, and the Test Antenna is at the same height as the EUT.
- 5. The EUT is commanded via the System Simulator (SS) to operate at the maximum output power i.e. Power Control Level (PCL) = 0 and Power Class = 1.
- 6. The BCCH number of the SS used here is 520. A communication link is established between the EUT and the SS.
- 7. The Spectrum Analyzer is set to max-peak detector function and maximum hold mode.

5.1.3 Frequency Stability Test



- 1. The test is performed in a Temperature Chamber.
- 2. The EUT is configured as MS + DC Power Supply.
- 3. The BCCH number of the SS used here is 520.

6. FREQUENCIES

6.1. Requirement

According to FCC §24.229, the frequencies available in the Broadband PCS services are listed as below, in accordance with the frequency allocations table of FCC §2.106.

(a) The following frequency blocks are available for assignment on an MTA basis:

```
Block A: 1850 - 1865MHz paired with 1930 - 1945MHz;
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Block B: 1870 - 1885MHz paired with 1950 - 1965MHz.

(b) The following frequency blocks are available for assignment on a BTA basis:

Block C: 1895 - 1910 MHz paired with 1975 - 1990MHz;

Block D: 1865 - 1870 MHz paired with 1945 - 1950MHz;

Block E: 1885 - 1890 MHz paired with 1965 - 1970MHz;

Block F: 1890 - 1895 MHz paired with 1970 - 1975MHz.

6.2 Test Procedure

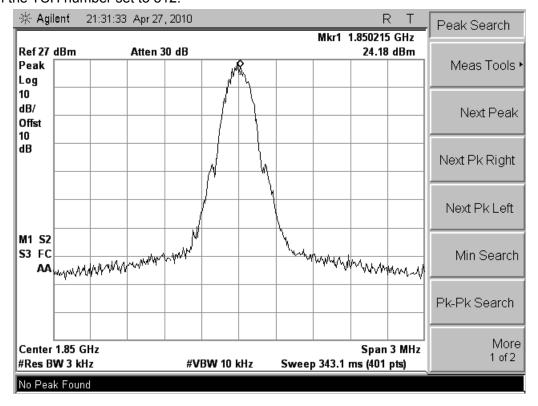
- 1. Perform test system setup as section 5.1.1.
- The resolution bandwidth of the Spectrum Analyzer is set to at lease one percent of the emission bandwidth of the fundamental emission of the transmitter, e.g. for GSM modulated signal (here used): RBW=VBW=3kHz, for CDMA modulated signal: RBW=VBW=30kHz.
- 3. The lowest and the highest channels are selected to perform tests respectively. Set the TCH number to 512 via the SS as the lowest channel.
- 4. Set the frequency range of the Spectrum Analyzer suitably to capture the waveform; search peak and mark it; finally record the plot.
- 5. Set the TCH number to 810 as the highest channel, then repeat step 4.

6.3 Test Result

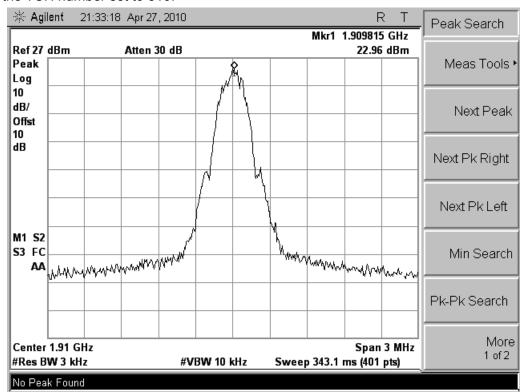
The transmitter (Tx) frequency arrangement of the PCS 1900MHz band is represented with a formula

F(n)=1850.2+0.2*(n-512), $512 \le n \le 810$. The frequencies of the lowest channel and the highest channel are listed as follows.

1. Plot when the TCH number set to 512:



2. Plot when the TCH number set to 810:



7. Conducted RF Output Power

7.1 Requirement

According to FCC §2.1046(a), for transmitters other than single sideband, independent sideband and controlled carrier radiotelephone, power output shall be measured at the RF output terminals when the transmitter is adjusted in accordance with the tune-up procedure to give the values of current and voltage on the circuit elements specified in §2.1033(c)(8). The electrical characteristics of the radio frequency load attached to the output terminals when this test is made shall be stated.

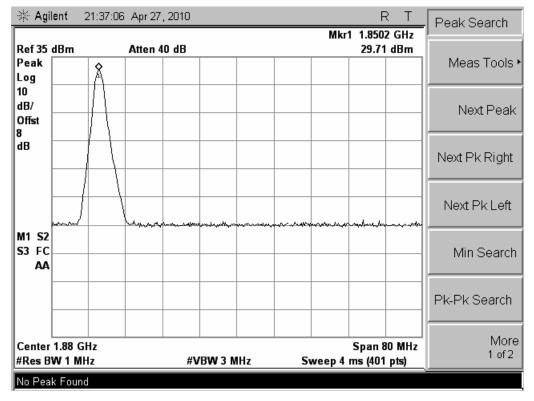
7.2 Test Procedure

- 1. Perform test system setup as section 5.1.1 (the radio frequency load attached to the EUT antenna terminal is 50Ω).
- 2. The resolution bandwidth of the Spectrum Analyzer is set to be comparable to the emission bandwidth of the transmitter, e.g. for GSM modulated signal (here used): RBW=VBW=1MHz, for CDMA modulated signal: RBW=VBW=3MHz.
- 3. The low, middle and the high channels are selected to perform tests respectively. Set the TCH number to 512 as the low channel.
- 4. Set the frequency range of the Spectrum Analyzer suitably to capture the waveform; search peak and mark it; finally record the peak and the plot.
- 5. Set the TCH number to 661 as the middle channel, then repeat step 4.
- 6. Set the TCH number to 810 as the high channel, then repeat step 4.

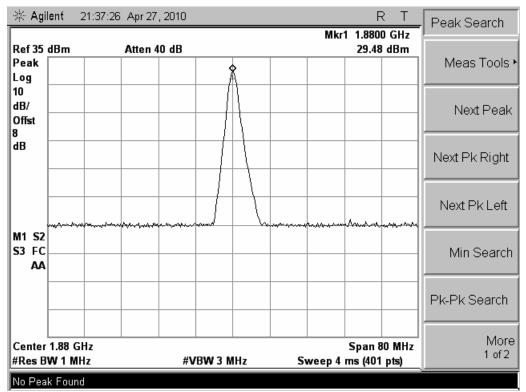
7.3 Test Result

No.	Channel Number	Frequency (MHz)	Measure	ed Power	Rated Po	wer
No. Charmer Number		r requericy (IVII IZ)	dBm	W	dBm	W
1	512	1850.2	29.71	0.935	30	1
2	661	1880.0	29.48	0.887	30	1
3	810	1909.8	28.39	0.690	30	1

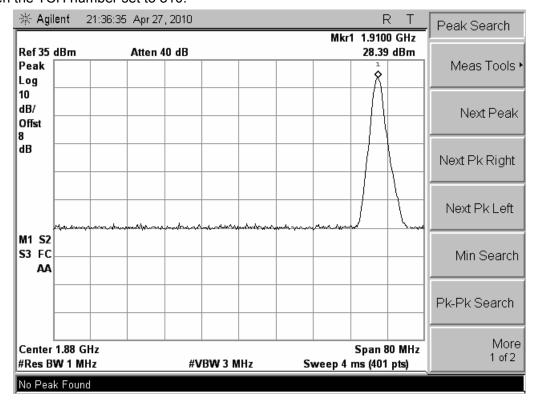
1. Plot when the TCH number set to 512:



2. Plot when the TCH number set to 661:



3. Plot when the TCH number set to 810:



8. OCCUPIED BANDWIDTH

8.1 Occupied Bandwidth Definition

According to FCC §2.1049, the occupied bandwidth is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission.

Occupied bandwidth is also known as the 99% emission bandwidth, or 20dB bandwidth (10*log1% is equal to 20dB) taking the total RF output power as reference.

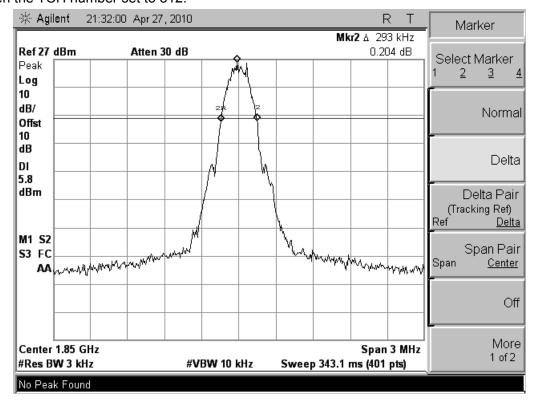
8.2 Test Procedure

- Perform test system setup as section 5.1.1
- 2. The resolution bandwidth of the Spectrum Analyzer is set to at least one percent of the emission bandwidth, e.g. for GSM modulated signal (here used): RBW=VBW=3 kHz, for CDMA modulated signal: RBW=VBW=30 kHz.
- 3. The low, middle and the high channels are selected to perform tests respectively. Set the TCH number to 512 as the low channel.
- 4. Set the frequency range of the Spectrum Analyzer suitably to capture the waveform; search peak; make a line whose value is 20dB lower than the peak; mark two points which the line intersected the waveform at; finally record the delta of the two points as the occupied bandwidth and the plot.
- 5. Set the TCH number to 661 as middle channel, then repeat step 4.
- 6. Set the TCH number to 810 as high channel, then repeat step 4.

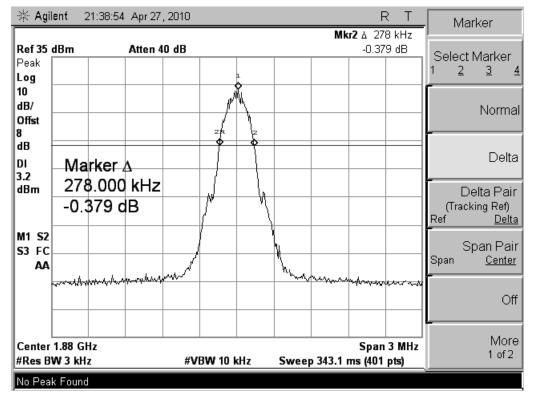
8.3 Test Result

No.	Channel	Frequency (MHz)	Measured Occupied Bandwidth (kHz)
1	512	1850.2	293.0
2	661	1880.0	278.0
3	810	1909.8	293.0

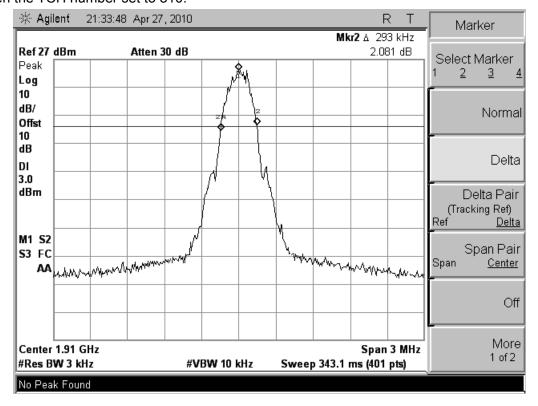
1. Plot when the TCH number set to 512:



2. Plot when the TCH number set to 661:



3. Plot when the TCH number set to 810:



9. CONDUCTED SPURIOUS EMISSION

9.1 Requirement

 According to FCC §24.238(a), the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43+10*log(P)dB. This calculated to be -13dBm.

 According to FCC §24.238(b), in the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. Thus the 26dB emission bandwidth is measurement for showing compliance at the band-edge.

9.2 Test Procedure

- 1. Perform test system setup as section section 5.1.1.
- 2. Make a limit line whose value is -13dBm on the Spectrum Analyzer.
- The lowest, middle and the highest channels are selected to perform tests respectively. Set the TCH number to 512 as the lowest channel.
- 4. Set the RBW of the Spectrum Analyzer to 1MHz, and the measuring frequency range from 9kHz to 10th harmonic of the fundamental frequency (here used 26.5GHz); mark the fundamental frequency and the harmonics thereof; finally record the harmonics and the plot. Note, the measuring frequency range can be divided into several parts to perform tests.
- 5. In the 1MHz bands immediately outside and adjacent to the frequency black, the RBW of the Spectrum Analyzer was set to at least one percent of the emission bandwidth of the fundamental emission of the transmitter, e.g. for GSM modulated signal (here used): RBW=3kHz, for CDMA modulated signal: RBW=30kHz.
- 6. Set the TCH number to 661 as the middle channel, then repeat step 4.
- 7. Set the TCH number to 810 as the highest channel, then repeat step 4 and 5.

9.3 Test Result

Table for the Harmonics and Plots for the Spurious Emission

1. Table for the Harmonics:

NOTE: "---" in the table following means that the emission power was too small to be measured and was at least 12dB below the limit.

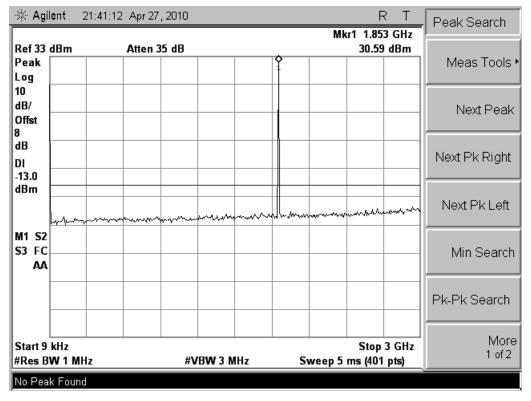
No.	Frequency (MHz)	Emission Power (dBm)	Limit (dBm)
	TCH	number set to 512 (1850.20MHz)	
1	3690.00		-13
2	5590.60	-32.19	-13
3	7400.80		-13
4	9251.00		-13
5	11101.20		-13
6	12951.40		-13
7	14801.60		-13
8	16651.80		-13
9	18502.00		-13
		number set to 661 (1880.00MHz)	•
10	3750.00		-13
11	5640.00	-33.05	-13
12	7520.00		-13
13	9400.00		-13
14	11280.00		-13
15	13160.00		-13
16	15040.00		-13
17	16920.00		-13
18	18800.00		-13
	TCH	number set to 810 (1909.80MHz)	
19	3810.00		-13
20	5750.40	-30.68	-13
21	7639.20		-13
22	9549.00		-13
23	11458.80		-13
24	13368.60		-13
25	15278.40		-13
26	17188.20		-13
27	19098.00		-13

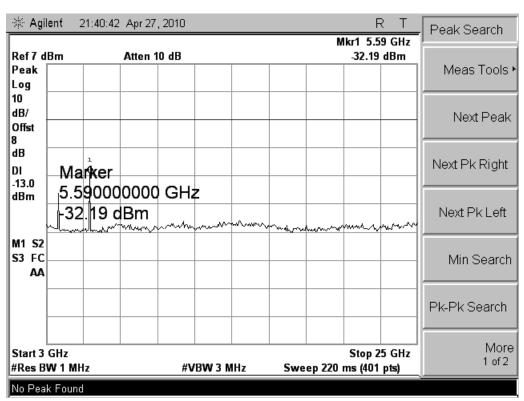
2. Plot for Spurious Emission:

The measuring frequency range was from 9 kHz to 25GHz.

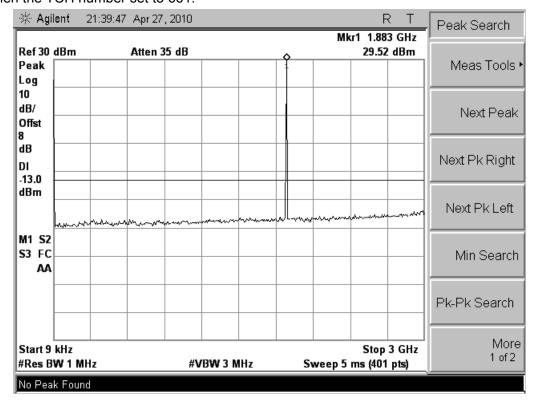
NOTE: The marker points are the Mobile Phone and/or System Simulator transmitting frequencies which should be ignored.

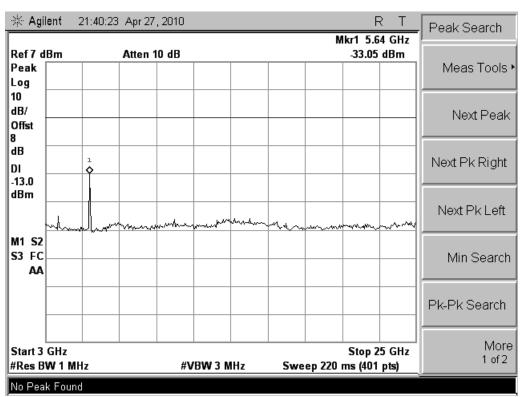
2.1 Plot when the TCH number set to 512:



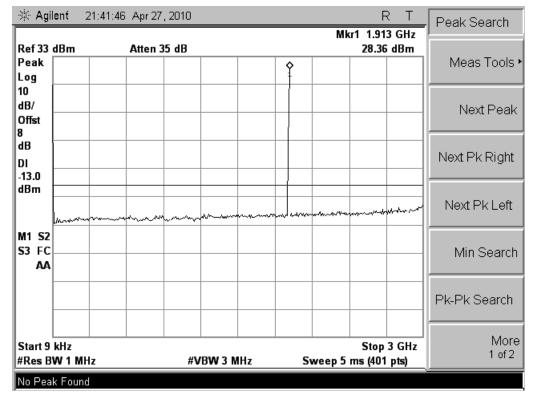


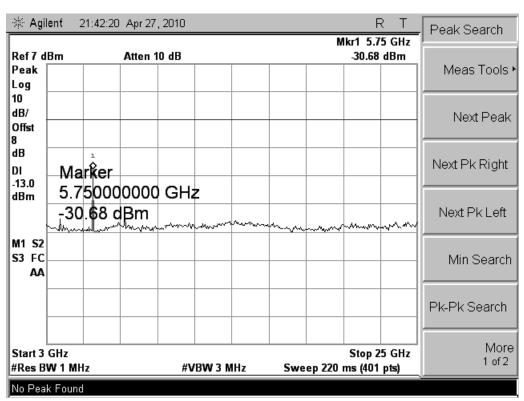
2.2 Plot when the TCH number set to 661:





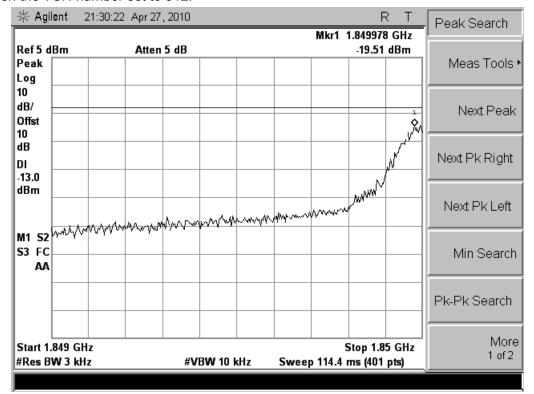
2.3 Plot when the TCH number set to 810:



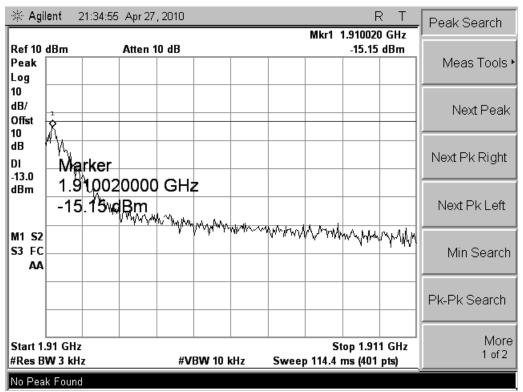


3. Plot for Band-edge

3.1 Plot when the TCH number set to 512:



3.2 Plot when the TCH number set to 810:



10. Transmitter Radiated Power (EIRP/ERP)

10.1 Requirement

According to FCC §24.232, the EIRP of Cellular mobile transmitters must not exceed 2 Watts (33dBm) e.i.r.p peak power.

10.2 Test Procedure

- 1. Perform test system setup as section 5.1.1.
- 2. The resolution bandwidth of the Spectrum Analyzer is set to be comparable to the emission bandwidth of the transmitter, e.g. for GSM modulated signal (here used): RBW=VBW=1MHz, for CDMA modulated signal: RBW=VBW=3MHz.
- 3. The low, middle and the high channels are selected to perform tests respectively. Set the TCH number to 512 as the low channel.
- 4. Employ the bi-log Test Antenna as the test system receiving antenna; set the polarization of the Test Antenna to be the same as that of the EUT transmitting antenna.
- 5. Set the frequency range of the Spectrum Analyzer suitably to capture the waveform; actuate the Turn Table to turn from 0 degrees to 360 degrees to find the maximum reading via the Spectrum Analyzer, mark the peak; finally record the peak and the plot.
- 6. Set the TCH number to 661 as the middle channel, then repeat step 5.
- 7. Set the TCH number to 810 as the high channel, then repeat step 5.

10.3 Test Result

No.	Channel	Eroguenov (MUz)	Measure	ed EIRP	Limit EIRP		Result	
INO.	Chamilei	Frequency (MHz)	dBm	W	dBm	W	Result	
1	512	1850.20	29.65	0.923	< 33.0	< 2	PASS	
2	661	1880.00	29.43	0.877	< 33.0	< 2	PASS	
3	810	1909.80	29.30	0.851	< 33.0	< 2	PASS	

11. Radiated Spurious Emission

11.1 Requirement

According to FCC §24.238(a), the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43+10*log(P)dB. This calculated to be -13dBm.

11.2 Test Procedure

- 1. Perform test system setup as section 5.1.2.
- 2. Make a limit line whose value is -13dBm on the Spectrum Analyzer, and set the RBW of the Spectrum Analyzer to 1MHz.
- 3. The low, middle and the high channels are selected to perform tests respectively. Set the TCH number to 512 as the low channel.
- 4. Employ the bi-log Test Antenna as the test system receiving antenna and set the frequency range of the Spectrum Analyzer from 30MHz to 3GHz.
- 5. The measurement is performed with the Test Antenna at both horizontal and vertical polarization respectively. Set the polarization of the Test Antenna to be horizontal.
- 6. Actuate the Turn Table to turn from 0 degrees to 360 degrees to find the maximum reading via the Spectrum Analyzer, mark the fundamental frequency and the harmonics thereof, after then record the harmonics and the plot.
- 7. Set the polarization of the Test Antenna to be vertical, then repeat step 6.
- 8. Employ the horn Test Antenna as the test system receiving antenna and set the frequency range of the Spectrum Analyzer from 3GHz to 10th harmonic of the fundamental frequency (here used 10GHz), then repeat step 5 to 7.
- 9. Set the TCH number to 661 as the middle channel, then repeat step 4 to 8.
- 10. Set the TCH number to 810 as the high channel, then repeat step 4 to 8.

11.3 Test Result

Table for the Harmonics

NOTE: "---" in the table following means that the emission power was too small to be measured and was at least 12dB below the limit.

No.	Eroguenov (MUz)	Emission	Limit (dDm)				
No. Frequency (MHz)		Test Antenna Vertical	Test Antenna Horizontal	Limit (dBm)			
	TCH number set to 512 (1850.20MHz)						
1	3700.40	-26.78	-30.45	-13			
2	5550.60			-13			
3	7400.80			-13			
4	9251.00			-13			
5	11101.20			-13			
6	12951.40			-13			
7	14801.60			-13			
8	16651.80			-13			
9	18502.00			-13			
	1	TCH number set to 661	(1880.0MHz)	-			
10	3760.00	-28.12	-31.06	-13			
11	5640.00			-13			
12	7520.00			-13			
13	9400.00			-13			
14	11280.00			-13			
15	13160.00			-13			
16	15040.00			-13			
17	16920.00			-13			
18	18800.00			-13			
	1	TCH number set to 810	(1909.80MHz)	-			
19	3819.60	-26.83	-30.69	-13			
20	5729.40			-13			
21	7639.20			-13			
22	9549.00			-13			
23	11458.80			-13			
24	13368.60			-13			
25	15278.40			-13			
26	17188.20			-13			
27	19098.00			-13			

12. Frequency Stability

12.1 Frequency Stability Requirement

According to FCC §24.235, the frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block.

According to FCC §2.1055, the test conditions are:

(a) Temperature:

The temperature is varied from -30°C to +50°C at intervals of not more than 10°C.

(b) Primary Supply Voltage:

For hand carried battery powered equipment, the primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacture. The supply voltage shall be measured at the input to the cable normally provided with the equipment, or at the power supply terminals if cables are not normally provided.

12.2 Test Procedure

- 1. Perform test system setup as section 5.1.3.
- 2. Set the voltage of the DC Power Supply to normal supply voltage (here used 3.7V) and the temperature of the Temperature Chamber to vary from -30°C to +50°C at intervals of 10°C.
- 3. At each temperature level, the EUT is powered off and kept in the Temperature Chamber for two hours. 4. After sufficient stabilization, turn on the EUT, command it via the System Simulator (SS) to operate at the maximum output power i.e. Power Control Level (PCL) = 0 and Power Class = 1, and then establish a communication link between the EUT and the SS.
- The low, middle and the high channels are selected to perform tests respectively. Set the TCH number to 512 as the low channel.
- 6. The frequency deviation is measured (directly read from the SS, which can report the parameter) within three minutes.
- 7. Set the TCH number to 661 as the middle channel, then repeat step 5.
- 8. Set the TCH number to 810 as the high channel, then repeat step 5.
- 9. Adjust the temperature of the Temperature Chamber as specified in step 2, then repeat step 3 to 7.
- 10. Set the voltage of the DC Power Supply to high extreme supply voltage (here used 4.2V) and the temperature of the Temperature Chamber to normal (here used +22°C), then repeat step 3 to 8.
- 11. Set the voltage of the DC Power Supply to low extreme supply voltage (here used 3.6V) and the temperature of the Temperature Chamber to normal (here used +22°C), then repeat step 3 to 8.

12.3 Test Result

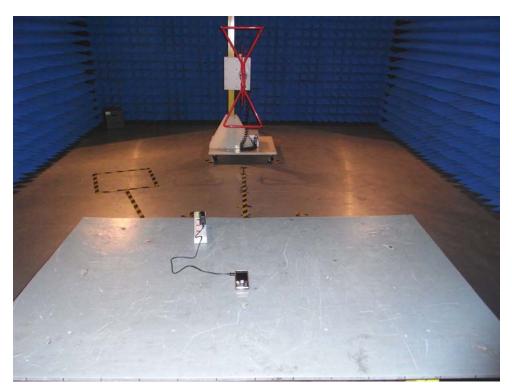
No.	Test Conditions		Frequency Deviation (Hz) at Channels Used			
	Voltage	Temperature	512	661	810	Limit (±2.5ppm)
1		-30°C	-55.0	-56.32	-58.21	
2		-20°C	-51.59	-49.32	-50.68	
3		-10°C	-42.85	-41.16	-40.84	
4		0°C	-39.90	-38.82	-36.65	
5	V-nor	+10°C	24.43	-31.52	-32.24	(a) ±1850Hz at 512 Channel
6		+20°C	-30.05	-35.45	-38.79	(b) ±1880Hz at 661 Channel
7		+30°C	-38.66	-38.29	-37.41	(c) ±1910Hz at 810 Channel
8		+40°C	-40.22	-43.41	-42.43	
9		+50°C	-48.06	-49.35	-47.18	
10	V-high	+22°C	30.90	-31.64	32.63	
11	V-low	+22°C	-38.85	-35.39	-37.95	
Result: PASS						

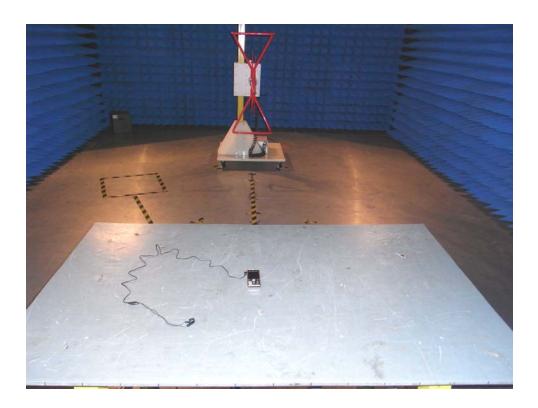
APPENDIX 1 PHOTOGRAPHS OF TEST SETUP

CONDUCTED TEST SETUP



RADIATED EMISSION TEST SETUP





APPENDIX 2 PHOTOGRAPHS OF EUT

FRONT VIEW OF SAMPLE



BACK VIEW OF SAMPLE



LEFT VIEW OF SAMPLE



RIGHT VIEW OF SAMPLE



TOP VIEW OF SAMPLE



BOTTOM VIEW OF SAMPLE



PHOTO OF POWER SUPPLY



PHOTO OF USB CABLE



PHOTO OF BATTERY



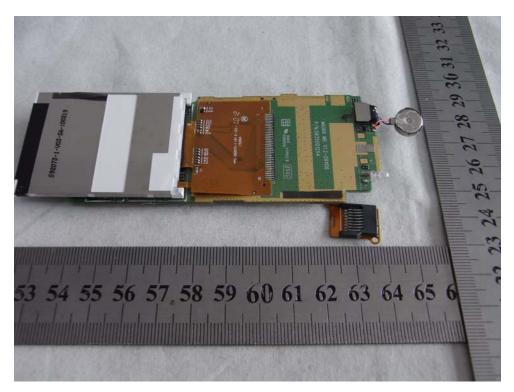
PHOTO OF THE ENTIRE SAMPLE



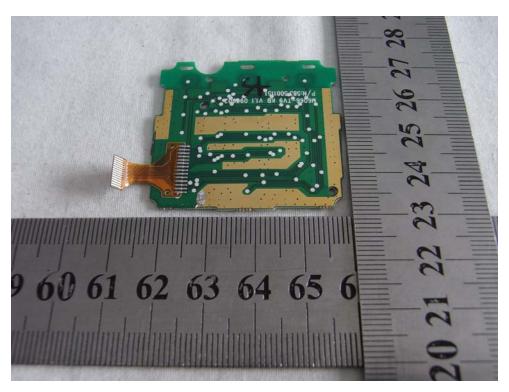
INTERNAL PHOTO OF SAMPLE - 1



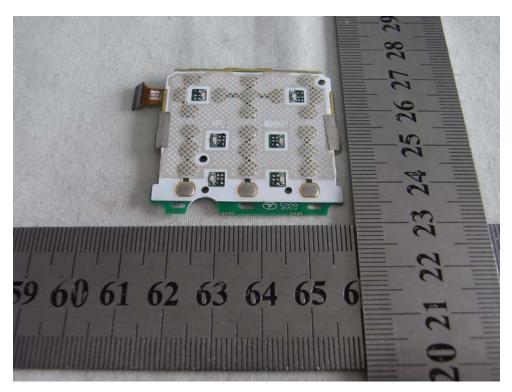
INTERNAL PHOTO OF SAMPLE -2



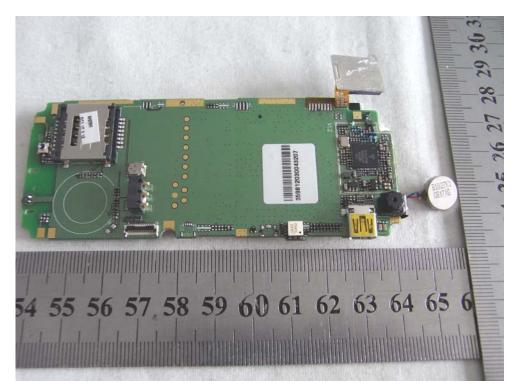
INTERNAL PHOTO OF SAMPLE -3



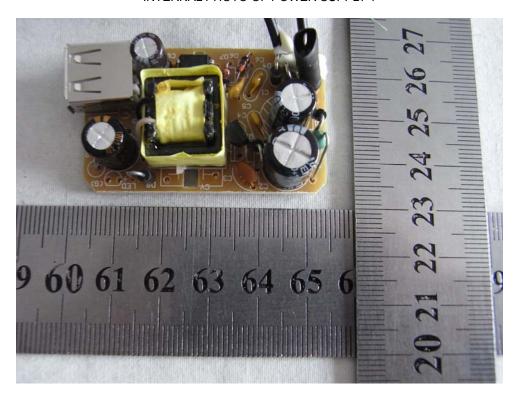
INTERNAL PHOTO OF SAMPLE -4



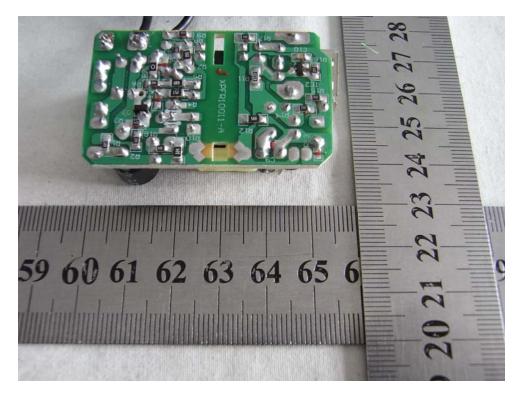
INTERNAL PHOTO OF SAMPLE - 5



INTERNAL PHOTO OF POWER SUPPLY-1



INTERNAL PHOTO OF POWER SUPPLY-2



-----END OF REPORT-----